


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,818	CHEN, SHIH-HONG	
	Examiner	Art Unit	
	Michael C. Wimer	2828	

SEARCHED			
Class	Subclass	Date	Examiner
343	757,765, 880,882	8/31/2005	MCW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR